8-Bit CMOS Digital Temperature Sensor with ADC Output

FEATURES

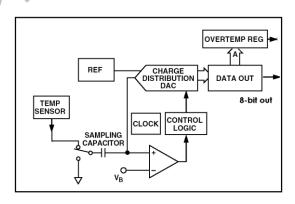
8-Bit ADC with 1ms Conversion Times
On-Chip Temperature Sensor: -20°C to +108°C
Over-temperature Indicator
Automatic Power-Down at the End of a
Conversion
Wide Operating Supply Range: 2.7 V to 5.5 V
Parallel or Serial Digital Output for SoC
Integration

APPLICATIONS
Personal Computers
Ambient Temperature Monitoring
Battery-Charging Applications
Industrial Process Control
Automotive

GENERAL DESCRIPTION

This analog block has an 8-bit single channel ADC with an on-chip temperature sensor that can operate from a single 2.7 V to 5.5 V power supply. The ADC is a 1ms successive approximation converter. Within the block, a temperature sensor, a clock oscillator and a sample-and-hold are present. When a conversion is initiated, the resulting ADC code at the end of the conversion gives a measurement of the chip or ambient temperature ($\pm 3^{\circ}\text{C}$ @ 25°C un-calibrated or \pm 1°C calibrated). On-chip register can be programmed to provide an over-temperature indicator, which becomes active when a programmed limit is exceeded.

FUNCTIONAL BLOCK DIAGRAM

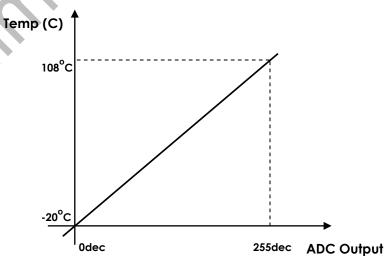


SPECIFICATIONS (VDD = 2.8 V to 5.5 V, GND = 0 V, unless otherwise noted.)

Parameter	Value	Unit
DC ACCURACY		
Resolution	8	Bits
Differential Nonlinearity	±1	LSB (typical)
Relative Accuracy	±1	LSB (typical)
Gain Error	±5	LSB (typical)
Offset Error	±5	LSB (typical)
TEMPERATURE SENSOR		
Error @ 25C	±3 or ±1 (calibrated)	°C (typical)
Temperature Resolution	0.5	°C/LSB (typical)
CONVERTION RATE		
Convertion Time	1	ms (typical)
DIGITAL OUTPUTS		
Output Low Voltage, VOL	GND ± 0.1	V
Output High Voltage, VOH	VDD ± 0.1	V
POWER REQUIREMENTS		
VDD	2.8 - 5.5	V
IDD	300	uA (typical)
IDD power down	<1	uA

TEMPERATURE MEASUREMENT

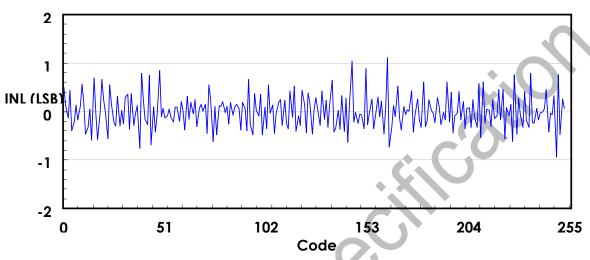
The typical transfer characteristic of the temperature sensor is shown below. The results of the 8-bit conversion can be converter to degree Celsius by using 0.5°C/LSB and offset with -20°C. Ideal temperature versus ADC output characteristics:



TYPICAL MEASURED ERROR

Below is a typical measured silicon INL error of the ADC and temperature measurement:

8-bit Temperature Output INL



TIMING DIAGRAM OF THE DIGITAL OUTPUT

